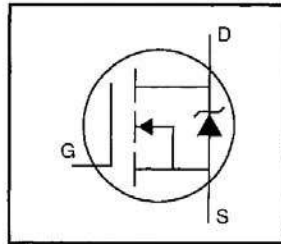


IRFP054PbF

HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Isolated Central Mounting Hole
- 175°C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Lead-Free



$$V_{DSS} = 60V$$

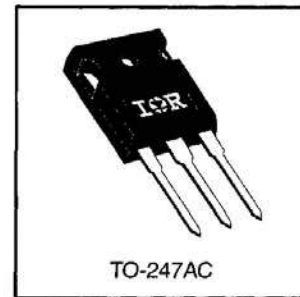
$$R_{DS(on)} = 0.014\Omega$$

$$I_D = 70^*A$$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.



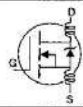
Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------|--|-----------------------|-------|
| $I_D @ T_C = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10 V$ | 70* | A |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10 V$ | 64 | |
| I_{DM} | Pulsed Drain Current ① | 360 | |
| $P_D @ T_C = 25^\circ C$ | Power Dissipation | 230 | W |
| | Linear Derating Factor | 1.5 | W/°C |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| E_{AS} | Single Pulse Avalanche Energy ② | 640 | mJ |
| dv/dt | Peak Diode Recovery dv/dt ③ | 4.5 | V/ns |
| T_J T_{STG} | Operating Junction and Storage Temperature Range | -55 to +175 | °C |
| | Soldering Temperature, for 10 seconds | 300 (1.6mm from case) | |
| | Mounting Torque, 6-32 or M3 screw | 10 lbf•in (1.1 N•m) | |

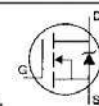
Thermal Resistance

| | Parameter | Min. | Typ. | Max. | Units |
|-----------------|-------------------------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | — | — | 0.65 | °C/W |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | — | 0.24 | — | |
| $R_{\theta JA}$ | Junction-to-Ambient | — | — | 40 | |

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|--------------------------------------|--------------------------------------|------|-------|-------|-------|--|
| V _{(BR)DSS} | Drain-to-Source Breakdown Voltage | 60 | — | — | V | V _{GS} =0V, I _D =250μA |
| ΔV _{(BR)DSS/ΔT_J} | Breakdown Voltage Temp. Coefficient | — | 0.056 | — | V/°C | Reference to 25°C, I _D =1mA |
| R _{DS(on)} | Static Drain-to-Source On-Resistance | — | — | 0.014 | Ω | V _{GS} =10V, I _D =54A ④ |
| V _{GS(th)} | Gate Threshold Voltage | 2.0 | — | 4.0 | V | V _{DS} =V _{GS} , I _D =250μA |
| g _{fs} | Forward Transconductance | 25 | — | — | S | V _{DS} =25V, I _D =54A ④ |
| I _{DSS} | Drain-to-Source Leakage Current | — | — | 25 | μA | V _{DS} =60V, V _{GS} =0V |
| | | — | — | 250 | | V _{DS} =48V, V _{GS} =0V, T _J =150°C |
| I _{GSS} | Gate-to-Source Forward Leakage | — | — | 100 | nA | V _{GS} =20V |
| | Gate-to-Source Reverse Leakage | — | — | -100 | | V _{GS} =-20V |
| Q _g | Total Gate Charge | — | — | 160 | nC | I _D =64A |
| Q _{gs} | Gate-to-Source Charge | — | — | 48 | | V _{DS} =48V |
| Q _{gd} | Gate-to-Drain ("Miller") Charge | — | — | 54 | | V _{GS} =10V See Fig. 6 and 13 ④ |
| t _{d(on)} | Turn-On Delay Time | — | 20 | — | ns | V _{DD} =30V |
| t _r | Rise Time | — | 160 | — | | I _D =64A |
| t _{d(off)} | Turn-Off Delay Time | — | 83 | — | | R _G =6.2Ω |
| t _f | Fall Time | — | 150 | — | | R _D =0.45Ω See Figure 10 ④ |
| L _D | Internal Drain Inductance | — | 5.0 | — | nH | Between lead, 6 mm (0.25in.) from package and center of die contact |
| L _S | Internal Source Inductance | — | 13 | — | |  |
| C _{iss} | Input Capacitance | — | 4500 | — | pF | V _{GS} =0V |
| C _{oss} | Output Capacitance | — | 2000 | — | | V _{DS} =25V |
| C _{rss} | Reverse Transfer Capacitance | — | 300 | — | | f=1.0MHz See Figure 5 |

Source-Drain Ratings and Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|-----------------|--|--|------|------|-------|--|
| I _S | Continuous Source Current (Body Diode) | — | — | 70* | A | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I _{SM} | Pulsed Source Current (Body Diode) ① | — | — | 360 | | |
| V _{SD} | Diode Forward Voltage | — | — | 2.5 | V | T _J =25°C, I _S =90A, V _{GS} =0V ④ |
| t _{rr} | Reverse Recovery Time | — | 270 | 540 | ns | T _J =25°C, I _F =64A |
| Q _{rr} | Reverse Recovery Charge | — | 1.1 | 2.2 | μC | di/dt=100A/μs ④ |
| t _{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | | |

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ② V_{DD}=25V, starting T_J=25°C, L=92μH, R_G=25Ω, I_{AS}=90A (See Figure 12)
- ③ I_{SD}≤90A, di/dt≤200A/μs, V_{DD}≤V_{(BR)DSS}, T_J≤175°C
- ④ Pulse width ≤ 300 μs; duty cycle ≤2%
- * Current limited by the package, (Die Current =90A)

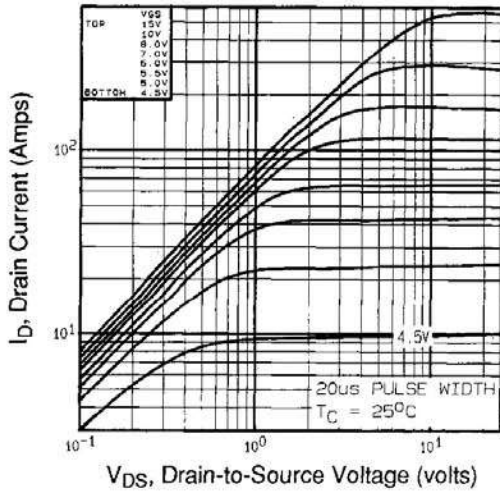


Fig 1. Typical Output Characteristics,
 $T_C=25^\circ\text{C}$

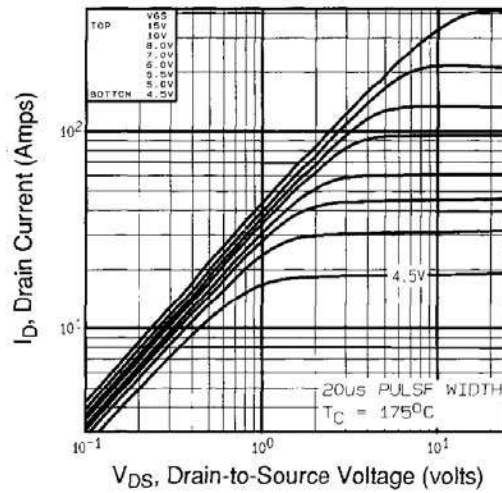


Fig 2. Typical Output Characteristics,
 $T_C=175^\circ\text{C}$

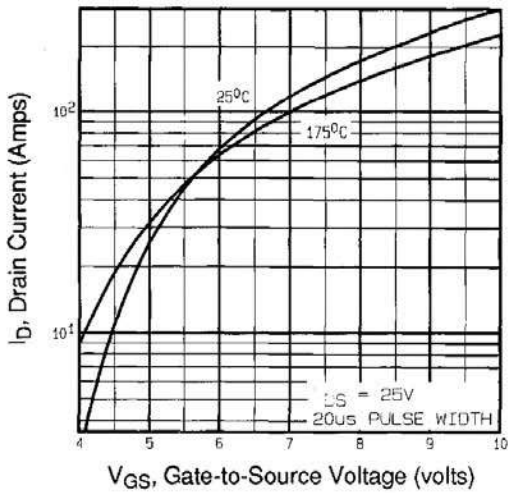


Fig 3. Typical Transfer Characteristics

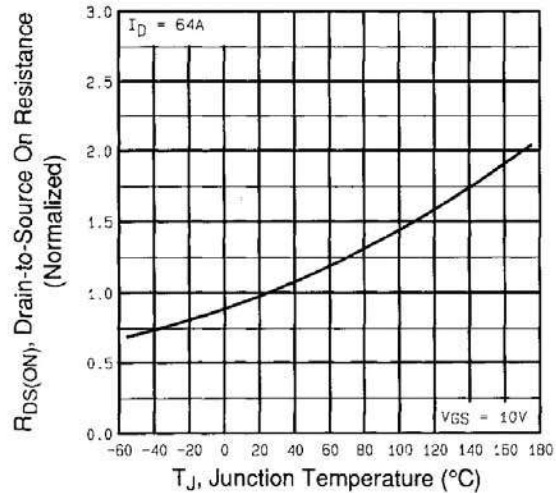


Fig 4. Normalized On-Resistance
 Vs. Temperature

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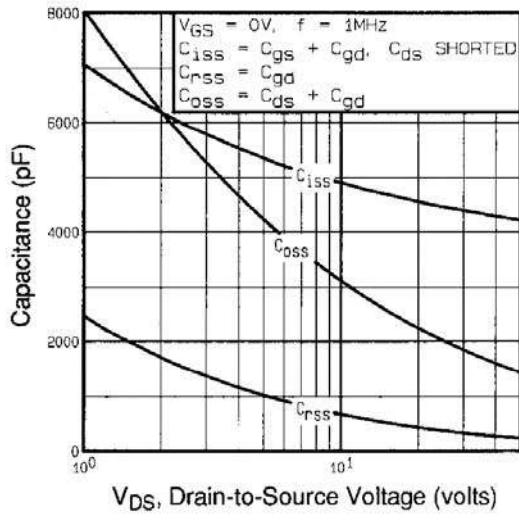


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

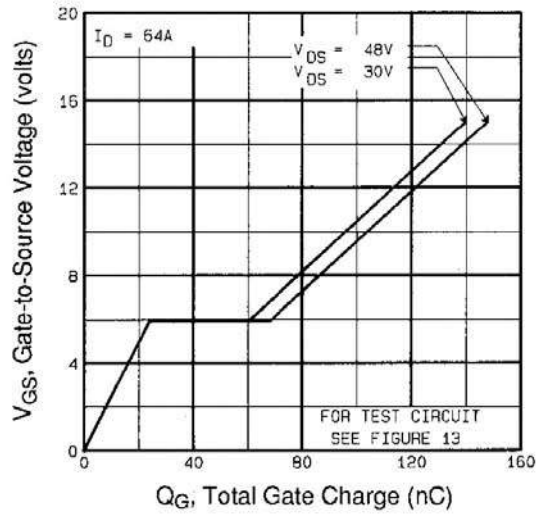


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

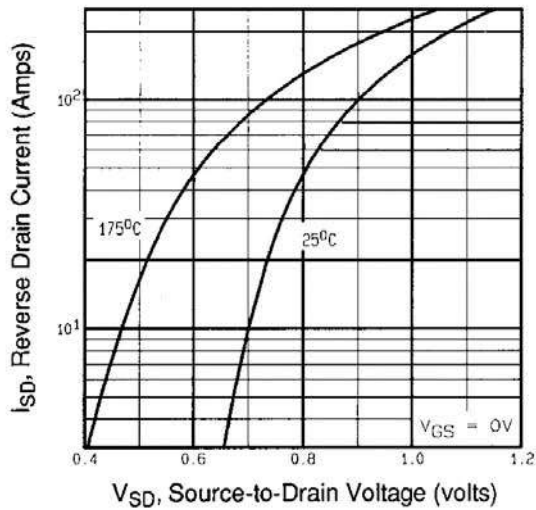


Fig 7. Typical Source-Drain Diode Forward Voltage

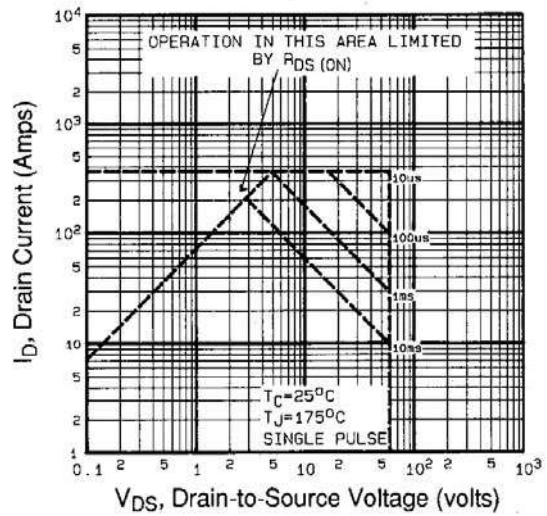


Fig 8. Maximum Safe Operating Area

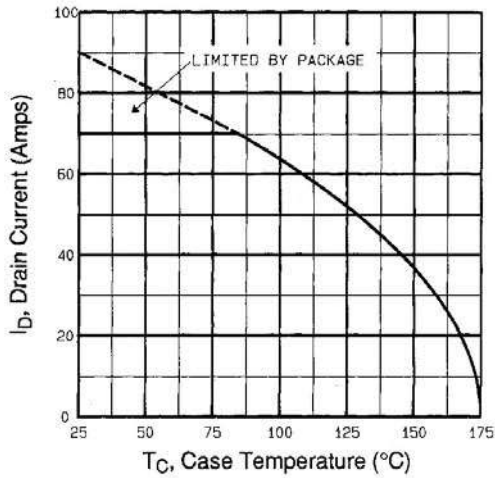


Fig 9. Maximum Drain Current Vs. Case Temperature

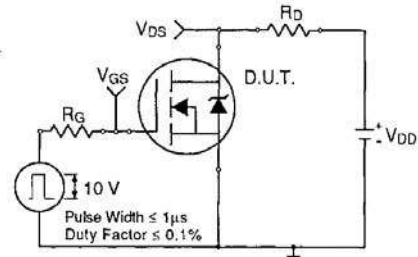


Fig 10a. Switching Time Test Circuit

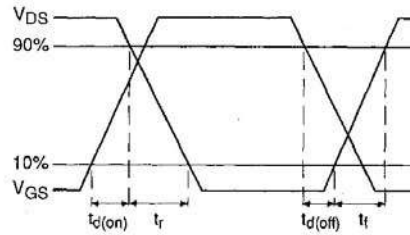


Fig 10b. Switching Time Waveforms

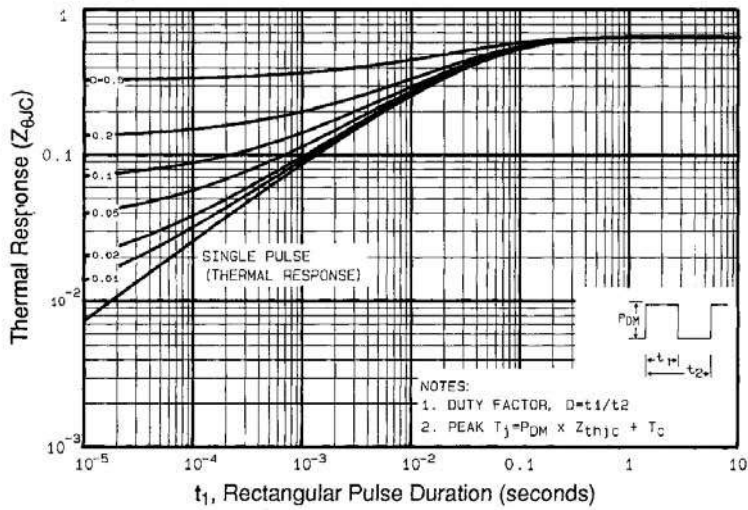


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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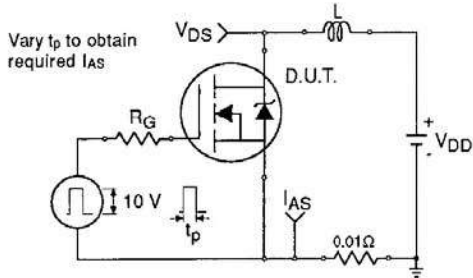


Fig 12a. Unclamped Inductive Test Circuit

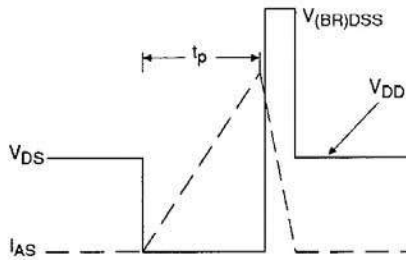


Fig 12b. Unclamped Inductive Waveforms

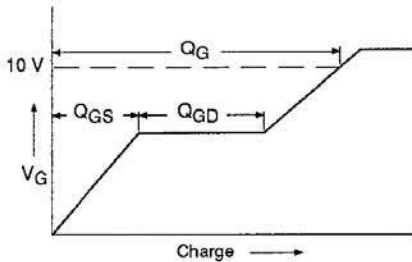


Fig 13a. Basic Gate Charge Waveform

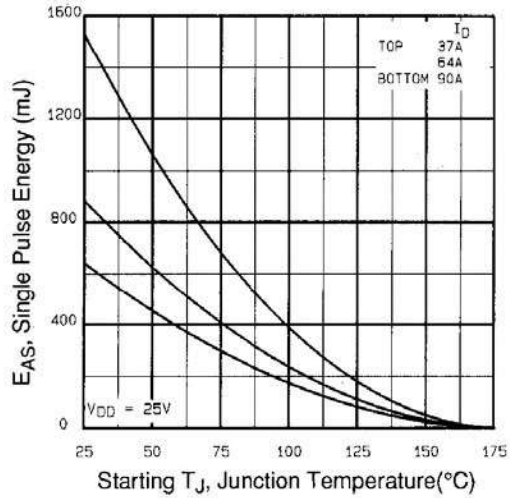


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

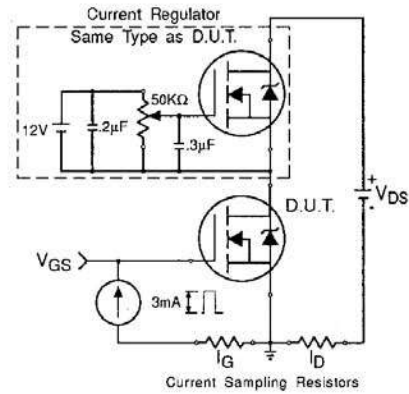


Fig 13b. Gate Charge Test Circuit

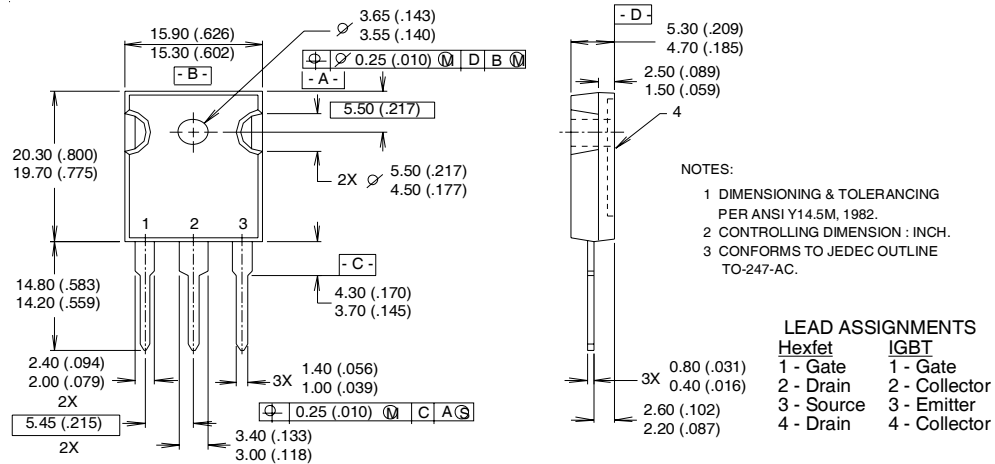
Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit – See page 1505

Appendix B: Package Outline Mechanical Drawing – See page 1511

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TO-247AC Package Outline

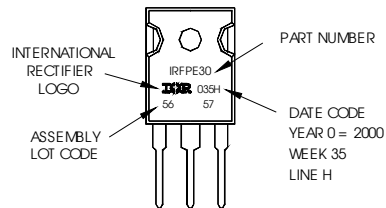
Dimensions are shown in millimeters (inches)



TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFPE30
 WITH ASSEMBLY
 LOT CODE 5657
 ASSEMBLED ON WW 35, 2000
 IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.



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